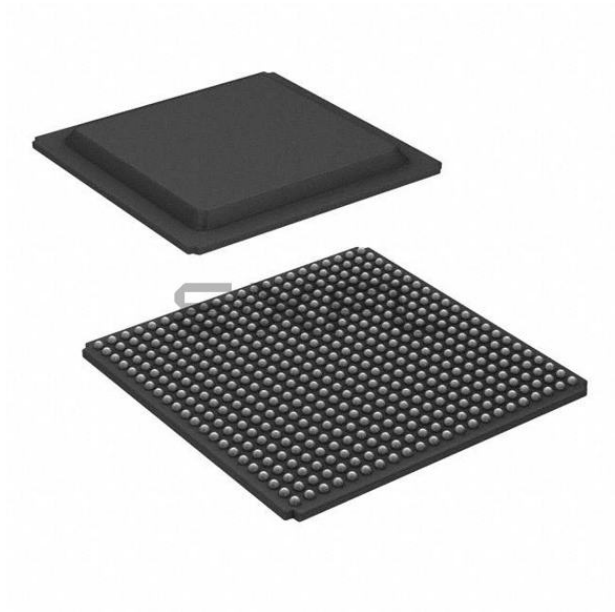
AMD Xilinx - XC3S1400A-4FGG484C Datasheet



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Details	
Product Status	Active
Number of LABs/CLBs	2816
Number of Logic Elements/Cells	25344
Total RAM Bits	589824
Number of I/O	375
Number of Gates	1400000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	484-BBGA
Supplier Device Package	484-FBGA (23x23)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3s1400a-4fgg484c

Power Supply Specifications

Table 5: **Supply Voltage Thresholds for Power-On Reset**

Symbol	Description	Min	Max	Units
V_{CCINTT}	Threshold for the V_{CCINT} supply	0.4	1.0	V
V_{CCAUXT}	Threshold for the V_{CCAUX} supply	1.0	2.0	V
V_{CCO2T}	Threshold for the V_{CCO} Bank 2 supply	1.0	2.0	V

Notes:

1. V_{CCINT}, V_{CCAUX}, and V_{CCO} supplies to the FPGA can be applied in any order. However, the FPGA's configuration source (Platform Flash, SPI Flash, parallel NOR Flash, microcontroller) might have specific requirements. Check the data sheet for the attached configuration source. Apply V_{CCINT} last for lowest overall power consumption (see UG331 chapter "Powering Spartan-3 Generation FPGAs" for more information).
2. To ensure successful power-on, V_{CCINT}, V_{CCO} Bank 2, and V_{CCAUX} supplies must rise through their respective threshold-voltage ranges with no dips at any point.

Table 6: **Supply Voltage Ramp Rate**

Symbol	Description	Min	Max	Units
V_{CCINTR}	Ramp rate from GND to valid V_{CCINT} supply level	0.2	100	ms
V_{CCAUXR}	Ramp rate from GND to valid V_{CCAUX} supply level	0.2	100	ms
V_{CCO2R}	Ramp rate from GND to valid V_{CCO} Bank 2 supply level	0.2	100	ms

Notes:

1. V_{CCINT}, V_{CCAUX}, and V_{CCO} supplies to the FPGA can be applied in any order. However, the FPGA's configuration source (Platform Flash, SPI Flash, parallel NOR Flash, microcontroller) might have specific requirements. Check the data sheet for the attached configuration source. Apply V_{CCINT} last for lowest overall power consumption (see UG331 chapter "Powering Spartan-3 Generation FPGAs" for more information).
2. To ensure successful power-on, V_{CCINT}, V_{CCO} Bank 2, and V_{CCAUX} supplies must rise through their respective threshold-voltage ranges with no dips at any point.

Table 7: **Supply Voltage Levels Necessary for Preserving CMOS Configuration Latch (CCL) Contents and RAM Data**

Symbol	Description	Min	Units
V_{DRINT}	V_{CCINT} level required to retain CMOS Configuration Latch (CCL) and RAM data	1.0	V
V_{DRAUX}	V_{CCAUX} level required to retain CMOS Configuration Latch (CCL) and RAM data	2.0	V

I/O Timing

Pin-to-Pin Clock-to-Output Times

Table 18: **Pin-to-Pin Clock-to-Output Times for the IOB Output Path**

Symbol	Description	Conditions	Device	Speed Grade		Units
				-5	-4	
				Max	Max	
Clock-to-Output Times						
$T_{ICKOFDCM}$	When reading from the Output Flip-Flop (OFF), the time from the active transition on the Global Clock pin to data appearing at the Output pin. The DCM is in use.	LVCMOS25(2), 12mA output drive, Fast slew rate, with DCM(3)	XC3S50A	3.18	3.42	ns
			XC3S200A	3.21	3.27	ns
			XC3S400A	2.97	3.33	ns
			XC3S700A	3.39	3.50	ns
			XC3S1400A	3.51	3.99	ns
T_{ICKOF}	When reading from OFF, the time from the active transition on the Global Clock pin to data appearing at the Output pin. The DCM is not in use.	LVCMOS25(2), 12mA output drive, Fast slew rate, without DCM	XC3S50A	4.59	5.02	ns
			XC3S200A	4.88	5.24	ns
			XC3S400A	4.68	5.12	ns
			XC3S700A	4.97	5.34	ns
			XC3S1400A	5.06	5.69	ns

Notes:

1. The numbers in this table are tested using the methodology presented in Table 27 and are based on the operating conditions set forth in Table 8 and Table 11.
2. This clock-to-output time requires adjustment whenever a signal standard other than LVCMOS25 is assigned to the Global Clock Input or a standard other than LVCMOS25 with 12 mA drive and Fast slew rate is assigned to the data Output. If the former is true, *add* the appropriate Input adjustment from Table 23. If the latter is true, *add* the appropriate Output adjustment from Table 26.
3. DCM output jitter is included in all measurements.

Input Setup and Hold Times

Table 20: **Setup and Hold Times for the IOB Input Path**

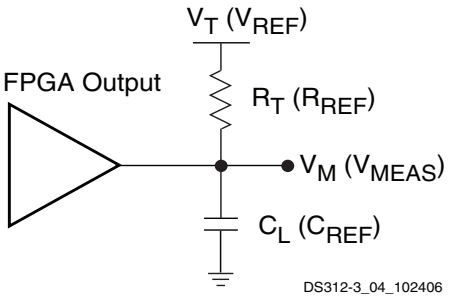
Symbol	Description	Conditions	IFD_DELAY_VALUE	Device	Speed Grade		Units
					-5	-4	
					Min	Min	
Setup Times							
T_{IOPICK}	Time from the setup of data at the Input pin to the active transition at the ICLK input of the Input Flip-Flop (IFF). No Input Delay is programmed.	LVCMOS25(2)	0	XC3S50A	1.56	1.58	ns
				XC3S200A	1.71	1.81	ns
				XC3S400A	1.30	1.51	ns
				XC3S700A	1.34	1.51	ns
				XC3S1400A	1.36	1.74	ns
$T_{IOPICKD}$	Time from the setup of data at the Input pin to the active transition at the ICLK input of the Input Flip-Flop (IFF). The Input Delay is programmed.	LVCMOS25(2)	1	XC3S50A	2.16	2.18	ns
			2		3.10	3.12	ns
			3		3.51	3.76	ns
			4		4.04	4.32	ns
			5		3.88	4.24	ns
			6		4.72	5.09	ns
			7		5.47	5.94	ns
			8		5.97	6.52	ns
			1	XC3S200A	2.05	2.20	ns
			2		2.72	2.93	ns
			3		3.38	3.78	ns
			4		3.88	4.37	ns
			5		3.69	4.20	ns
			6		4.56	5.23	ns
			7		5.34	6.11	ns
			8		5.85	6.71	ns
			1	XC3S400A	1.79	2.02	ns
			2		2.43	2.67	ns
			3		3.02	3.43	ns
			4		3.49	3.96	ns
			5		3.41	3.95	ns
			6		4.20	4.81	ns
			7		4.96	5.66	ns
			8		5.44	6.19	ns

Timing Measurement Methodology

When measuring timing parameters at the programmable I/Os, different signal standards call for different test conditions. Table 27 lists the conditions to use for each standard.

The method for measuring Input timing is as follows: A signal that swings between a Low logic level of V_L and a High logic level of V_H is applied to the Input under test. Some standards also require the application of a bias voltage to the V_{REF} pins of a given bank to properly set the input-switching threshold. The measurement point of the Input signal (V_M) is commonly located halfway between V_L and V_H.

The Output test setup is shown in Figure 9. A termination voltage V_T is applied to the termination resistor R_T, the other end of which is connected to the Output. For each standard, R_T and V_T generally take on the standard values recommended for minimizing signal reflections. If the standard does not ordinarily use terminations (for example, LVCMOS, LVTTL), then R_T is set to 1MΩ to indicate an open connection, and V_T is set to zero. The same measurement point (V_M) that was used at the Input is also used at the Output.



Notes:

1. The names shown in parentheses are used in the IBIS file.

Figure 9: **Output Test Setup**

Table 27: **Test Methods for Timing Measurement at I/Os**

Signal Standard (IOSTANDARD)		Inputs			Outputs		Inputs and Outputs
		V_{REF} (V)	V_L (V)	V_H (V)	R_T (Ω)	V_T (V)	V_M (V)
Single-Ended							
LVTTL		-	0	3.3	1M	0	1.4
LVCMOS33		-	0	3.3	1M	0	1.65
LVCMOS25		-	0	2.5	1M	0	1.25
LVCMOS18		-	0	1.8	1M	0	0.9
LVCMOS15		-	0	1.5	1M	0	0.75
LVCMOS12		-	0	1.2	1M	0	0.6
PCI33_3	Rising	-	Note 3	Note 3	25	0	0.94
	Falling				25	3.3	2.03
PCI66_3	Rising	-	Note 3	Note 3	25	0	0.94
	Falling				25	3.3	2.03
HSTL_I		0.75	V_{REF} – 0.5	V_{REF} + 0.5	50	0.75	V_{REF}
HSTL_III		0.9	V_{REF} – 0.5	V_{REF} + 0.5	50	1.5	V_{REF}
HSTL_I_18		0.9	V_{REF} – 0.5	V_{REF} + 0.5	50	0.9	V_{REF}
HSTL_II_18		0.9	V_{REF} – 0.5	V_{REF} + 0.5	25	0.9	V_{REF}
HSTL_III_18		1.1	V_{REF} – 0.5	V_{REF} + 0.5	50	1.8	V_{REF}
SSTL18_I		0.9	V_{REF} – 0.5	V_{REF} + 0.5	50	0.9	V_{REF}
SSTL18_II		0.9	V_{REF} – 0.5	V_{REF} + 0.5	25	0.9	V_{REF}
SSTL2_I		1.25	V_{REF} – 0.75	V_{REF} + 0.75	50	1.25	V_{REF}
SSTL2_II		1.25	V_{REF} – 0.75	V_{REF} + 0.75	25	1.25	V_{REF}
SSTL3_I		1.5	V_{REF} – 0.75	V_{REF} + 0.75	50	1.5	V_{REF}
SSTL3_II		1.5	V_{REF} – 0.75	V_{REF} + 0.75	25	1.5	V_{REF}

Table 29: **Recommended Number of Simultaneously Switching Outputs per VCCO-GND Pair (V_{CCAUX}=3.3V)*(Continued)***

Signal Standard (IOSTANDARD)	Package Type			
	VQ100, TQ144		FT256, FG320, FG400, FG484, FG676	
	Top, Bottom (Banks 0,2)	Left, Right (Banks 1,3)	Top, Bottom (Banks 0,2)	Left, Right (Banks 1,3)
Differential Standards (Number of I/O *Pairs* or Channels)				
LVDS_25	8	–	22	–
LVDS_33	8	–	27	–
BLVDS_25	1	1	4	4
MINI_LVDS_25	8	–	22	–
MINI_LVDS_33	8	–	27	–
LVPECL_25	Input Only			
LVPECL_33	Input Only			
RSDS_25	8	–	22	–
RSDS_33	8	–	27	–
TMDS_33	8	–	27	–
PPDS_25	8	–	22	–
PPDS_33	8	–	27	–
DIFF_HSTL_I	–	5	–	10
DIFF_HSTL_III	–	3	–	4
DIFF_HSTL_I_18	6	6	8	8
DIFF_HSTL_II_18	–	2	–	2
DIFF_HSTL_III_18	4	4	5	4
DIFF_SSTL18_I	3	6	3	7
DIFF_SSTL18_II	–	4	–	4
DIFF_SSTL2_I	5	5	9	9
DIFF_SSTL2_II	–	3	–	4
DIFF_SSTL3_I	3	4	4	5
DIFF_SSTL3_II	2	3	3	3

Notes:

1. Not all I/O standards are supported on all I/O banks. The left and right banks (I/O banks 1 and 3) support higher output drive current than the top and bottom banks (I/O banks 0 and 2). Similarly, true differential output standards, such as LVDS, RSDS, PPDS, miniLVDS, and TMDS, are only supported in top or bottom banks (I/O banks 0 and 2). Refer to UG331: *Spartan-3 Generation FPGA User Guide* for additional information.
2. The numbers in this table are recommendations that assume sound board lay out practice. Test limits are the V_{IL}/V_{IH} voltage limits for the respective I/O standard.
3. If more than one signal standard is assigned to the I/Os of a given bank, refer to XAPP689: *Managing Ground Bounce in Large FPGAs* for information on how to perform weighted average SSO calculations.

Table 31: **CLB Distributed RAM Switching Characteristics**

Symbol	Description	-5		-4		Units
		Min	Max	Min	Max	
Clock-to-Output Times						
T_{SHCKO}	Time from the active edge at the CLK input to data appearing on the distributed RAM output	–	1.69	–	2.01	ns
Setup Times						
T_{DS}	Setup time of data at the BX or BY input before the active transition at the CLK input of the distributed RAM	–0.07	–	–0.02	–	ns
T_{AS}	Setup time of the F/G address inputs before the active transition at the CLK input of the distributed RAM	0.18	–	0.36	–	ns
T_{WS}	Setup time of the write enable input before the active transition at the CLK input of the distributed RAM	0.30	–	0.59	–	ns
Hold Times						
T_{DH}	Hold time of the BX and BY data inputs after the active transition at the CLK input of the distributed RAM	0.13	–	0.13	–	ns
T_{AH}, T_{WH}	Hold time of the F/G address inputs or the write enable input after the active transition at the CLK input of the distributed RAM	0.01	–	0.01	–	ns
Clock Pulse Width						
T_{WPH}, T_{WPL}	Minimum High or Low pulse width at CLK input	0.88	–	1.01	–	ns

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 8.

Table 32: **CLB Shift Register Switching Characteristics**

Symbol	Description	-5		-4		Units
		Min	Max	Min	Max	
Clock-to-Output Times						
T_{REG}	Time from the active edge at the CLK input to data appearing on the shift register output	–	4.11	–	4.82	ns
Setup Times						
T_{SRLDS}	Setup time of data at the BX or BY input before the active transition at the CLK input of the shift register	0.13	–	0.18	–	ns
Hold Times						
T_{SRLDH}	Hold time of the BX or BY data input after the active transition at the CLK input of the shift register	0.16	–	0.16	–	ns
Clock Pulse Width						
T_{WPH}, T_{WPL}	Minimum High or Low pulse width at CLK input	0.90	–	1.01	–	ns

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 8.

Master Serial and Slave Serial Mode Timing

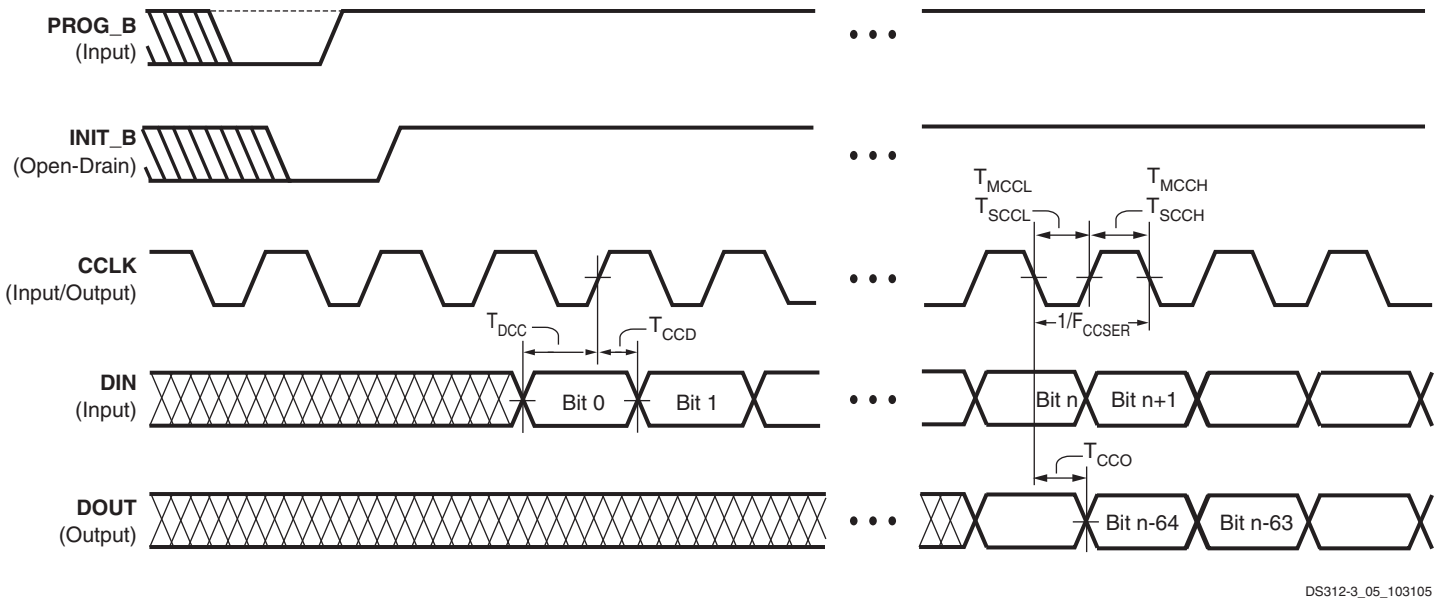


Figure 12: **Waveforms for Master Serial and Slave Serial Configuration**

Table 50: **Timing for the Master Serial and Slave Serial Configuration Modes**

Symbol	Description		Slave/ Master	All Speed Grades		Units
				Min	Max	
Clock-to-Output Times						
T_{CCO}	The time from the falling transition on the CCLK pin to data appearing at the DOUT pin		Both	1.5	10	ns
Setup Times						
T_{DCC}	The time from the setup of data at the DIN pin to the rising transition at the CCLK pin		Both	7	–	ns
Hold Times						
T_{CCD}	The time from the rising transition at the CCLK pin to the point when data is last held at the DIN pin		Master	0	–	ns
			Slave	1.0		
Clock Timing						
T_{CCH}	High pulse width at the CCLK input pin		Master	See Table 48		
			Slave	See Table 49		
T_{CCL}	Low pulse width at the CCLK input pin		Master	See Table 48		
			Slave	See Table 49		
F_{CCSER}	Frequency of the clock signal at the CCLK input pin	No bitstream compression	Slave	0	100	MHz
		With bitstream compression		0	100	MHz

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 8.
2. For serial configuration with a daisy-chain of multiple FPGAs, the maximum limit is 25 MHz.

Byte Peripheral Interface (BPI) Configuration Timing

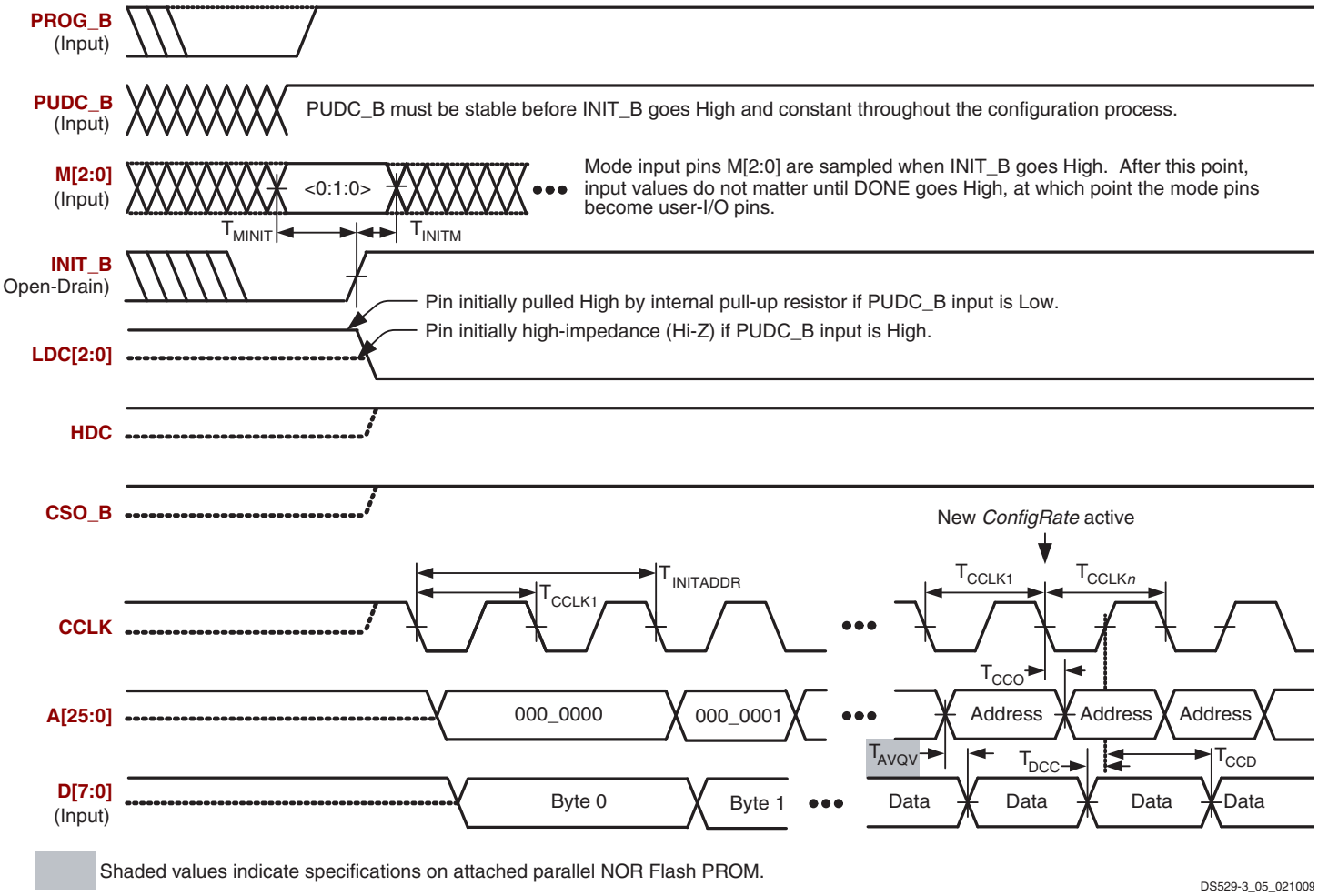


Figure 15: **Waveforms for Byte-wide Peripheral Interface (BPI) Configuration**

Table 54: **Timing for Byte-wide Peripheral Interface (BPI) Configuration Mode**

Symbol	Description	Minimum	Maximum	Units
T_{CCLK1}	Initial CCLK clock period	See Table 46		
T_{CCLKn}	CCLK clock period after FPGA loads ConfigRate setting	See Table 46		
T_{MINIT}	Setup time on M[2:0] mode pins before the rising edge of INIT_B	50	–	ns
T_{INITM}	Hold time on M[2:0] mode pins after the rising edge of INIT_B	0	–	ns
$T_{INITADDR}$	Minimum period of initial A[25:0] address cycle; LDC[2:0] and HDC are asserted and valid	5	5	T_{CCLK1} cycles
T_{CCO}	Address A[25:0] outputs valid after CCLK falling edge	See Table 50		
T_{DCC}	Setup time on D[7:0] data inputs before CCLK rising edge	See T_{SMDCC} in Table 51		
T_{CCD}	Hold time on D[7:0] data inputs after CCLK rising edge	0	–	ns

Revision History

The following table shows the revision history for this document.

Date	Version	Revision
12/05/06	1.0	Initial release.
02/02/07	1.1	Promoted to Preliminary status. Moved Table 15 to under "DC Electrical Characteristics" section. Updated all timing specifications for the v1.32 speed files. Added recommended Simultaneous Switching Output (SSO) limits in Table 29. Set a 10 µs maximum pulse width for the DNA_PORT READ signal and the JTAG clock input during the ISC_DNA command, affecting both Table 43 and Table 56. Described "External Termination Requirements for Differential I/O." Added separate DIN hold time for Slave mode in Table 50. Corrected wording in Table 52 and Table 54; no specifications affected.
03/16/07	1.2	Updated all AC timing specifications to the v1.34 speeds file. Promoted the XC3S700A and XC3S1400A FPGAs offered in the -4 speed grade to Production status, as shown in Table 16. Added Note 2 to Table 39 regarding the extra logic (one LUT) automatically added by ISE 9.1i and later software revisions for any DCM application that leverages the Digital Frequency Synthesizer (DFS). Separated some JTAG specifications by array size or function, as shown in Table 56. Updated quiescent current limits in Table 10.
04/23/07	1.3	Updated all AC timing specifications to the v1.35 speeds file. Promoted all devices except the XC3S400A to Production status, as shown in Table 16.
05/08/07	1.4	Updated XC3S400A to Production and v1.36 speeds file. Added banking rules and other explanatory footnotes to Table 12 and Table 13. Corrected DIFF_SSTL3_II V_{OL} Max in Table 14. Improved XC3S400A Pin-to-Pin Clock-to-Output times in Table 18. Updated XC3S400A Pin-to-Pin Setup Times in Table 19. Updated TIOICKPD for -5 in Table 20. Added SSO numbers to Table 28 and Table 29. Removed invalid Embedded Multiplier Hold Times in Table 34. Improved CLKOUT_FREQ_CLK90 in Table 37. Improved T_{TDITCK} and F_{TCK} performance for XC3S400A in Table 56.
07/10/07	1.5	Added DIFF_HSTL_I and DIFF_HSTL_III to Table 13, Table 14, Table 27, and Table 29. Updated TMDS DC characteristics in Table 14. Updated for speed file v1.37 in ISE 9.2.01i as shown in Table 17. Updated pin-to-pin setup and hold times in Table 19. Updated TMDS output adjustment in Table 26. Updated I/O Test Method values in Table 27. Added BLVDS SSO numbers inTable 29. For Multiplier block, updated setup times and added hold times to Table 34. Updated block RAM clock width in Table 35. Updated CLKOUT_PER_JITT_2X and CLKOUT_PER_JITT_DV2 in Table 37. Added CCLK specifications for Commercial in Table 46 through Table 48.
04/15/08	1.6	Added V_{IN} to Recommended Operating Conditions in Table 8 and added reference to XAPP459, "Eliminating I/O Coupling Effects when Interfacing Large-Swing Single-Ended Signals to User I/O Pins." Reduced typical I_{CCINTQ} and I_{CCAUXQ} quiescent current values by 12%-58% in Table 10. Increased V_{IL} max to 0.4V for LVCMOS12/15/18 and improved V_{IH} min to 0.7V for LVCMOS12 in Table 11. Changed V_{OL} max to 0.4V and V_{OH} min to V_{CCO}-0.4V for LVCMOS15/18 in Table 12. Noted latest speed file v1.39 in ISE 10.1 software in Table 16. Added new packages to SSO limits in Table 28 and Table 29. Improved SSTL18_II SSO limit for FG packages in Table 29. Improved F_{BUFG} for -4 to 334 MHz in Table 33. Added references to 375 MHz performance via SCD 4103 in Table 33,Table 38, Table 39, and Table 40. Restored Units column to Table 44. Updated CCLK output maximum period in Table 46 to match minimum frequency in Table 47. Corrected BPI active clock edge in Figure 15 and Table 54.
05/28/08	1.7	Improved V_{CCAUXT} and V_{CCO2T} POR minimum in Table 5 and updated V_{CCO} POR levels in Figure 11. Clarified recommended V_{IN} in Table 8. Added reference to V_{CCAUX} in "Simultaneously Switching Output Guidelines". Added reference to Sample Window in Table 21. Removed DNA_RETENTION limit of 10 years in Table 15 since number of Read cycles is the only unique limit. Added references to UG332.
03/06/09	1.8	Changed typical quiescent current temperature from ambient to junction. Updated BPI configuration waveforms in Figure 15 and updated Table 55. Updated selected I/O standard DC characteristics. Added TIOPI and TIOPID in Table 22. Removed references to SCD 4103.
08/19/10	2.0	Added I_{IK} to Table 4. Updated V_{IN} in Table 8 and footnoted I_L in Table 9 to note potential leakage between pins of a differential pair. Clarified LVPECL notes to Table 13. Corrected symbols for TSUSPEND_GTS and TSUSPEND_GWE in Table 44.

Introduction

This section describes how the various pins on a Spartan®-3A FPGA connect within the supported component packages, and provides device-specific thermal characteristics. For general information on the pin functions and the package characteristics, see the Packaging section of UG331: *Spartan-3 Generation FPGA User Guide*.

- **UG331: Spartan-3 Generation FPGA User Guide**
  www.xilinx.com/support/documentation/user_guides/ug331.pdf

Spartan-3A FPGAs are available in both standard and Pb-free, RoHS versions of each package, with the Pb-free version adding a "G" to the middle of the package code. Except for the thermal characteristics, all information for the standard package applies equally to the Pb-free package.

Pin Types

Most pins on a Spartan-3A FPGA are general-purpose, user-defined I/O pins. There are, however, up to 12 different functional types of pins on Spartan-3A FPGA packages, as outlined in Table 57. In the package footprint drawings that follow, the individual pins are color-coded according to pin type as in the table.

Table 57: **Types of Pins on Spartan-3A FPGAs**

Type / Color Code	Description	Pin Name(s) in Type
I/O	Unrestricted, general-purpose user-I/O pin. Most pins can be paired together to form differential I/Os.	IO_# IO_Lxxy_#
INPUT	Unrestricted, general-purpose input-only pin. This pin does not have an output structure, differential termination resistor, or PCI clamp diode.	IP_# IP_Lxxy_#
DUAL	Dual-purpose pin used in some configuration modes during the configuration process and then usually available as a user I/O after configuration. If the pin is not used during configuration, this pin behaves as an I/O-type pin. See UG332: *Spartan-3 Generation Configuration User Guide* for additional information on these signals.	M[2:0] PUDC_B CCLK MOSI/CSI_B D[7:1] D0/DIN DOUT CSO_B RDWR_B INIT_B A[25:0] VS[2:0] LDC[2:0] HDC
VREF	Dual-purpose pin that is either a user-I/O pin or Input-only pin, or, along with all other VREF pins in the same bank, provides a reference voltage input for certain I/O standards. If used for a reference voltage within a bank, all VREF pins within the bank must be connected.	IP/VREF_# IP_Lxxy_#/VREF_# IO/VREF_# IO_Lxxy_#/VREF_#
CLK	Either a user-I/O pin or an input to a specific clock buffer driver. Most packages have 16 global clock inputs that optionally clock the entire device. The exceptions are the TQ144 and the XC3S50A in the FT256 package). The RHCLK inputs optionally clock the right half of the device. The LHCLK inputs optionally clock the left half of the device. See the Using Global Clock Resources chapter in UG331: *Spartan-3 Generation FPGA User Guide* for additional information on these signals.	IO_Lxxy_#/GCLK[15:0], IO_Lxxy_#/LHCLK[7:0], IO_Lxxy_#/RHCLK[7:0]
CONFIG	Dedicated configuration pin, two per device. Not available as a user-I/O pin. Every package has two dedicated configuration pins. These pins are powered by VCCAUX. See the UG332: *Spartan-3 Generation Configuration User Guide* for additional information on the DONE and PROG_B signals.	DONE, PROG_B

VQ100 Footprint (XC3S50A)

Note pin 1 indicator in top-left corner and logo orientation.

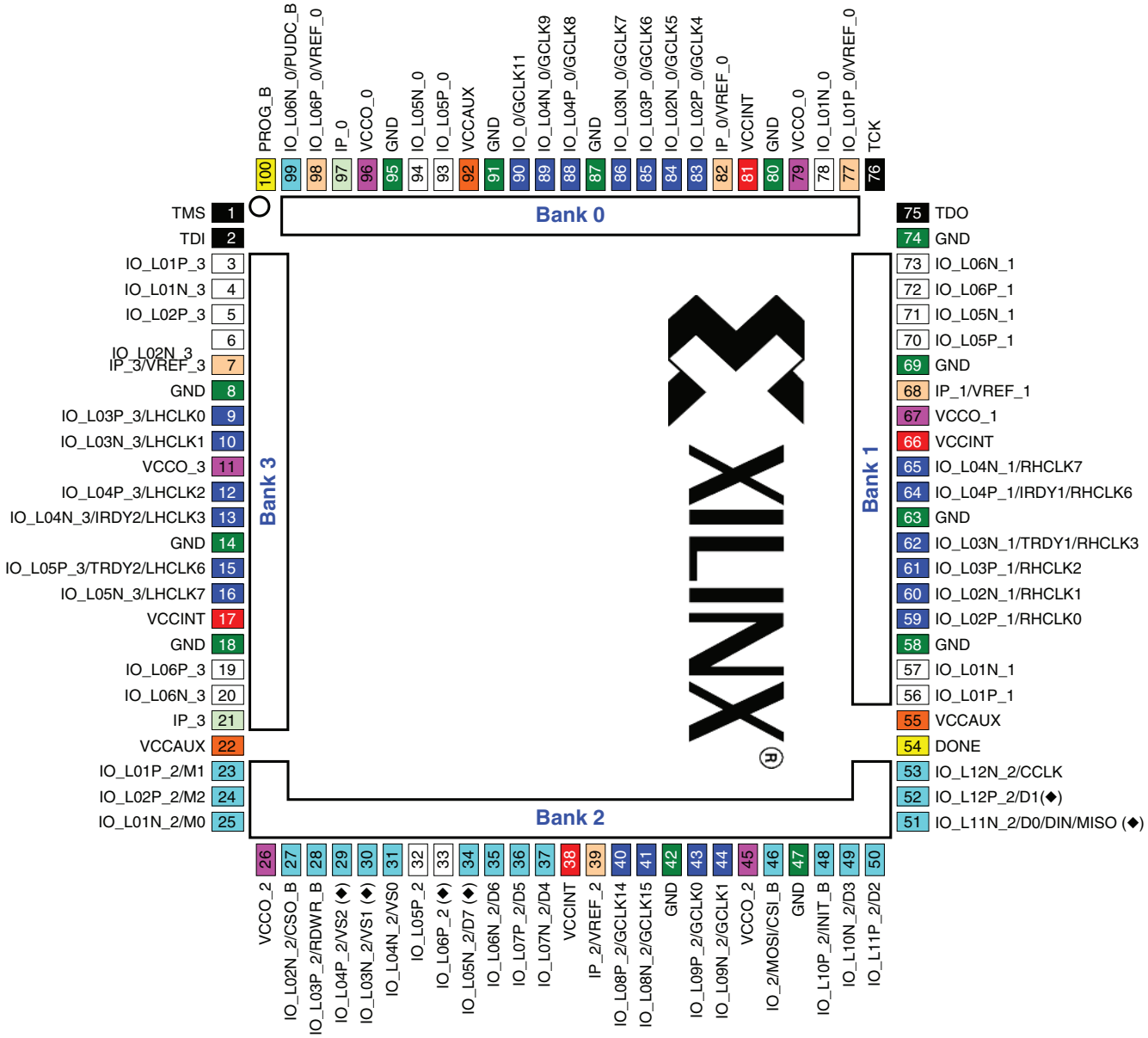


Figure 17: **VQ100 Package Footprint - XC3S50A (Top View)**

17	**I/O:** Unrestricted, general-purpose user I/O	20	**DUAL:** Configuration pins, then possible user I/O	6	**VREF:** User I/O or input voltage reference for bank
2	**INPUT:** Unrestricted, general-purpose input pin	23	**CLK:** User I/O, input, or global buffer input	6	**VCCO:** Output voltage supply for bank
2	**CONFIG:** Dedicated configuration pins	4	**JTAG:** Dedicated JTAG port pins	4	**VCCINT:** Internal core supply voltage (+1.2V)
0	**N.C.:** Not connected	13	**GND:** Ground	3	**VCCAUX:** Auxiliary supply voltage

Table 66: **Spartan-3A TQ144 Pinout*(Continued)***

Bank	Pin Name	Pin	Type
2	IO_L05P_2	P46	I/O
2	IO_L06N_2/D6	P49	DUAL
2	IO_L06P_2	P47	I/O
2	IO_L07N_2/D4	P51	DUAL
2	IO_L07P_2/D5	P50	DUAL
2	IO_L08N_2/GCLK15	P55	GCLK
2	IO_L08P_2/GCLK14	P54	GCLK
2	IO_L09N_2/GCLK1	P59	GCLK
2	IO_L09P_2/GCLK0	P57	GCLK
2	IO_L10N_2/GCLK3	P60	GCLK
2	IO_L10P_2/GCLK2	P58	GCLK
2	IO_L11N_2/DOUT	P64	DUAL
2	IO_L11P_2/AWAKE	P63	PWR MGMT
2	IO_L12N_2/D3	P68	DUAL
2	IO_L12P_2/INIT_B	P67	DUAL
2	IO_L13N_2/D0/DIN/MISO	P71	DUAL
2	IO_L13P_2/D2	P69	DUAL
2	IO_L14N_2/CCLK	P72	DUAL
2	IO_L14P_2/D1	P70	DUAL
2	IP_2/VREF_2	P53	VREF
2	VCCO_2	P40	VCCO
2	VCCO_2	P61	VCCO
3	IO_L01N_3	P6	I/O
3	IO_L01P_3	P4	I/O
3	IO_L02N_3	P5	I/O
3	IO_L02P_3	P3	I/O
3	IO_L03N_3	P8	I/O
3	IO_L03P_3	P7	I/O
3	IO_L04N_3/VREF_3	P11	VREF
3	IO_L04P_3	P10	I/O
3	IO_L05N_3/LHCLK1	P13	LHCLK
3	IO_L05P_3/LHCLK0	P12	LHCLK
3	IO_L06N_3/IRDY2/LHCLK3	P16	LHCLK
3	IO_L06P_3/LHCLK2	P15	LHCLK
3	IO_L07N_3/LHCLK5	P20	LHCLK
3	IO_L07P_3/LHCLK4	P18	LHCLK
3	IO_L08N_3/LHCLK7	P21	LHCLK
3	IO_L08P_3/TRDY2/LHCLK6	P19	LHCLK
3	IO_L09N_3	P25	I/O
3	IO_L09P_3	P24	I/O
3	IO_L10N_3	P29	I/O

Table 66: **Spartan-3A TQ144 Pinout*(Continued)***

Bank	Pin Name	Pin	Type
3	IO_L10P_3	P27	I/O
3	IO_L11N_3	P30	I/O
3	IO_L11P_3	P28	I/O
3	IO_L12N_3	P32	I/O
3	IO_L12P_3	P31	I/O
3	IP_L13N_3/VREF_3	P35	VREF
3	IP_L13P_3	P33	INPUT
3	VCCO_3	P14	VCCO
3	VCCO_3	P23	VCCO
GND	GND	P9	GND
GND	GND	P17	GND
GND	GND	P26	GND
GND	GND	P34	GND
GND	GND	P56	GND
GND	GND	P65	GND
GND	GND	P81	GND
GND	GND	P89	GND
GND	GND	P100	GND
GND	GND	P106	GND
GND	GND	P118	GND
GND	GND	P128	GND
GND	GND	P137	GND
VCCAUX	SUSPEND	P74	PWR MGMT
VCCAUX	DONE	P73	CONFIG
VCCAUX	PROG_B	P144	CONFIG
VCCAUX	TCK	P109	JTAG
VCCAUX	TDI	P2	JTAG
VCCAUX	TDO	P107	JTAG
VCCAUX	TMS	P1	JTAG
VCCAUX	VCCAUX	P36	VCCAUX
VCCAUX	VCCAUX	P66	VCCAUX
VCCAUX	VCCAUX	P108	VCCAUX
VCCAUX	VCCAUX	P133	VCCAUX
VCCINT	VCCINT	P22	VCCINT
VCCINT	VCCINT	P52	VCCINT
VCCINT	VCCINT	P94	VCCINT
VCCINT	VCCINT	P122	VCCINT

FT256: 256-ball Fine-pitch, Thin Ball Grid Array

The 256-ball fine-pitch, thin ball grid array package, FT256, supports all five Spartan-3A FPGAs. The XC3S200A and XC3S400A have identical footprints, and the XC3S700A and XC3S1400A have identical footprints. The XC3S50A is compatible with the XC3S200A/XC3S400A but has 51 unconnected balls. The XC3S200A/XC3S400A is similar to the XC3S700A/XC3S1400A, but the XC3S700A/XC3S1400A adds more power and ground pins and therefore is not compatible.

Table 68 lists all the package pins for the XC3S50A, XC3S200A, and XC3S400A. They are sorted by bank number and then by pin name of the largest device. Pins that form a differential I/O pair appear together in the table. The table also shows the pin number for each pin and the pin type, as defined earlier.

The highlighted rows indicate pinout differences between the XC3S50A, the XC3S200A, and the XC3S400A FPGAs. The XC3S50A has 51 unconnected balls, indicated as N.C. (No Connection) in Table 68 and Figure 20 and with the black diamond character (◆) in Table 68. Figure 21 provides the common footprint for the XC3S200A and XC3S400A.

Table 68 also indicates that some differential I/O pairs have different assignments between the XC3S50A and the XC3S200A/XC3S400A, highlighted in light blue. See "Footprint Migration Differences," page 99 for additional information.

All other balls have nearly identical functionality on all three devices. Table 73 summarizes the XC3S50A FPGA footprint migration differences for the FT256 package.

The XC3S50A does not support the address output pins for the Byte-wide Peripheral Interface (BPI) configuration mode.

Table 69 lists all the package pins for the XC3S700A and XC3S1400A. They are sorted by bank number and then by pin name. Pins that form a differential I/O pair appear together in the table. The table also shows the pin number for each pin and the pin type, as defined earlier. Figure 22 provides the common footprint for the XC3S200A and XC3S400A.

An electronic version of this package pinout table and footprint diagram is available for download from the Xilinx website at

www.xilinx.com/support/documentation/data_sheets/s3a_pin.zip.

Pinout Table

Table 68: **Spartan-3A FT256 Pinout (XC3S50A, XC3S200A, XC3S400)**

Bank	XC3S50A	XC3S200A XC3S400A	FT256 Ball	Type
0	IO_L01N_0	IO_L01N_0	C13	I/O
0	IO_L01P_0	IO_L01P_0	D13	I/O
0	IO_L02N_0	IO_L02N_0	B14	I/O
0	IO_L02P_0/ VREF_0	IO_L02P_0/ VREF_0	B15	VREF
0	IO_L03N_0	IO_L03N_0	D11	I/O
0	IO_L03P_0	IO_L03P_0	C12	I/O
0	IO_L04N_0	IO_L04N_0	A13	I/O
0	IO_L04P_0	IO_L04P_0	A14	I/O
0	N.C. (◆)	IO_L05N_0	A12	I/O
0	IP_0	IO_L05P_0	B12	I/O
0	N.C. (◆)	IO_L06N_0/ VREF_0	E10	VREF
0	N.C. (◆)	IO_L06P_0	D10	I/O
0	IO_L07N_0	IO_L07N_0	A11	I/O
0	IO_L07P_0	IO_L07P_0	C11	I/O
0	IO_L08N_0	IO_L08N_0	A10	I/O
0	IO_L08P_0	IO_L08P_0	B10	I/O
0	IO_L09N_0/ GCLK5	IO_L09N_0/ GCLK5	D9	GCLK
0	IO_L09P_0/ GCLK4	IO_L09P_0/ GCLK4	C10	GCLK
0	IO_L10N_0/ GCLK7	IO_L10N_0/ GCLK7	A9	GCLK
0	IO_L10P_0/ GCLK6	IO_L10P_0/ GCLK6	C9	GCLK
0	IO_L11N_0/ GCLK9	IO_L11N_0/ GCLK9	D8	GCLK
0	IO_L11P_0/ GCLK8	IO_L11P_0/ GCLK8	C8	GCLK
0	IO_L12N_0/ GCLK11	IO_L12N_0/ GCLK11	B8	GCLK
0	IO_L12P_0/ GCLK10	IO_L12P_0/ GCLK10	A8	GCLK
0	N.C. (◆)	IO_L13N_0	C7	I/O
0	N.C. (◆)	IO_L13P_0	A7	I/O
0	N.C. (◆)	IO_L14N_0/ VREF_0	E7	VREF
0	N.C. (◆)	IO_L14P_0	F8	I/O
0	IO_L15N_0	IO_L15N_0	B6	I/O
0	IO_L15P_0	IO_L15P_0	A6	I/O
0	IO_L16N_0	IO_L16N_0	C6	I/O
0	IO_L16P_0	IO_L16P_0	D7	I/O
0	IO_L17N_0	IO_L17N_0	C5	I/O

Table 69: **Spartan-3A FT256 Pinout (XC3S700A,**

Bank	XC3S700A XC3S1400A	FT256 Ball	Type
3	IO_L16N_3	L2	I/O
3	IO_L16P_3/VREF_3	L1	VREF
3	IO_L18N_3	L3	I/O
3	IO_L18P_3	K4	I/O
3	IO_L19N_3	L4	I/O
3	IO_L19P_3	M3	I/O
3	IO_L20N_3	N1	I/O
3	IO_L20P_3	M1	I/O
3	IO_L22N_3	P1	I/O
3	IO_L22P_3/VREF_3	N2	VREF
3	IO_L23N_3	P2	I/O
3	IO_L23P_3	R1	I/O
3	IO_L24N_3	M4	I/O
3	IO_L24P_3	N3	I/O
3	IP_3	J4	INPUT
3	IP_3/VREF_3	G4	VREF
3	IP_3/VREF_3	J5	VREF
3	VCCO_3	D2	VCCO
3	VCCO_3	H2	VCCO
3	VCCO_3	M2	VCCO
GND	GND	A1	GND
GND	GND	A16	GND
GND	GND	B11	GND
GND	GND	B7	GND
GND	GND	C14	GND
GND	GND	C3	GND
GND	GND	E10	GND
GND	GND	E12	GND
GND	GND	E5	GND
GND	GND	F11	GND
GND	GND	F2	GND
GND	GND	F6	GND
GND	GND	F7	GND
GND	GND	F8	GND
GND	GND	F9	GND
GND	GND	G10	GND
GND	GND	G12	GND
GND	GND	G15	GND
GND	GND	G5	GND
GND	GND	G6	GND

Table 69: **Spartan-3A FT256 Pinout (XC3S700A,**

Bank	XC3S700A XC3S1400A	FT256 Ball	Type
GND	GND	G8	GND
GND	GND	H11	GND
GND	GND	H5	GND
GND	GND	H7	GND
GND	GND	H9	GND
GND	GND	J10	GND
GND	GND	J6	GND
GND	GND	J8	GND
GND	GND	K11	GND
GND	GND	K12	GND
GND	GND	K2	GND
GND	GND	K5	GND
GND	GND	K7	GND
GND	GND	K9	GND
GND	GND	L10	GND
GND	GND	L11	GND
GND	GND	L15	GND
GND	GND	L6	GND
GND	GND	L8	GND
GND	GND	M12	GND
GND	GND	M5	GND
GND	GND	M8	GND
GND	GND	N10	GND
GND	GND	N7	GND
GND	GND	P14	GND
GND	GND	P3	GND
GND	GND	R10	GND
GND	GND	R6	GND
GND	GND	T1	GND
GND	GND	T16	GND
VCCAUX	SUSPEND	R16	PWRMGT
VCCAUX	DONE	T15	CONFIG
VCCAUX	PROG_B	A2	CONFIG
VCCAUX	TCK	A15	JTAG
VCCAUX	TDI	B1	JTAG
VCCAUX	TDO	B16	JTAG
VCCAUX	TMS	B2	JTAG
VCCAUX	VCCAUX	D6	VCCAUX
VCCAUX	VCCAUX	E11	VCCAUX
VCCAUX	VCCAUX	F12	VCCAUX

Footprint Migration Differences

Unconnected Balls on XC3S50A

Table 73 summarizes any footprint and functionality differences between the XC3S50A and the XC3S200A or XC3S400A FPGAs that might affect easy migration between these devices in the FT256 package. The XC3S200A and XC3S400A have identical pinouts. The XC3S50A pinout is compatible, but there are 52 balls that are different. Generally, designs easily migrate upward from the XC3S50A to either the XC3S200A or XC3S400A. If using differential I/O, see Table 74. If using the BPI configuration mode (parallel Flash), see Table 75.

Table 73: **FT256 XC3S50A Footprint Migration Difference**

FT256 Ball	Bank	XC3S50A Type	Migration	XC3S200A/ XC3S400A Type
A7	0	N.C.	→	I/O
A12	0	N.C.	→	I/O
B12	0	INPUT	→	I/O
C7	0	N.C.	→	I/O
D10	0	N.C.	→	I/O
E2	3	N.C.	→	I/O
E3	3	N.C.	→	I/O
E7	0	N.C.	→	I/O
E10	0	N.C.	→	I/O
E16	1	N.C.	→	I/O
F3	3	N.C.	→	I/O
F8	0	N.C.	→	I/O
F14	1	N.C.	→	I/O
F15	1	N.C.	→	I/O
F16	1	N.C.	→	I/O
G3	3	N.C.	→	I/O
G4	3	N.C.	→	I/O
G5	3	N.C.	→	INPUT
G6	3	N.C.	→	INPUT
G13	1	N.C.	→	I/O
G14	1	N.C.	→	I/O
G16	1	N.C.	→	I/O
H4	3	N.C.	→	I/O
H5	3	N.C.	→	I/O
H6	3	N.C.	→	I/O
H13	1	N.C.	→	I/O
J4	3	N.C.	→	I/O
J6	3	N.C.	→	I/O
J10	1	N.C.	→	INPUT
J11	1	N.C.	→	INPUT
K4	3	N.C.	→	I/O
K13	1	N.C.	→	I/O
L1	3	N.C.	→	I/O
L2	3	N.C.	→	I/O
L3	3	N.C.	→	I/O
L4	3	N.C.	→	I/O
L13	1	N.C.	→	I/O
L14	1	N.C.	→	I/O
L16	1	N.C.	→	I/O
M3	3	N.C.	→	I/O
M10	2	N.C.	→	I/O
M13	1	N.C.	→	I/O
M14	1	N.C.	→	I/O
M15	1	N.C.	→	I/O
M16	1	N.C.	→	I/O
N7	2	N.C.	→	I/O
N10	2	N.C.	→	I/O
N12	2	N.C.	→	I/O
P6	2	N.C.	→	I/O
P13	2	N.C.	→	I/O
R7	2	N.C.	→	I/O
T7	2	N.C.	→	I/O
DIFFERENCES			**52**	

Legend:

→ This pin can unconditionally migrate from the device on the left to the device on the right. Migration in the other direction is possible depending on how the pin is configured for the device on the right.

Table 77: **Spartan-3A FG320 Pinout *(Continued)***

Bank	Pin Name	FG320 Ball	Type
GND	GND	R15	GND
GND	GND	T9	GND
GND	GND	V1	GND
GND	GND	V7	GND
GND	GND	V12	GND
GND	GND	V18	GND
VCCAUX	SUSPEND	T16	PWR MGMT
VCCAUX	DONE	V17	CONFIG
VCCAUX	PROG_B	C4	CONFIG
VCCAUX	TCK	A17	JTAG
VCCAUX	TDI	E4	JTAG
VCCAUX	TDO	E14	JTAG
VCCAUX	TMS	C3	JTAG
VCCAUX	VCCAUX	A9	VCCAUX
VCCAUX	VCCAUX	G10	VCCAUX
VCCAUX	VCCAUX	J12	VCCAUX
VCCAUX	VCCAUX	J18	VCCAUX
VCCAUX	VCCAUX	K1	VCCAUX
VCCAUX	VCCAUX	K7	VCCAUX
VCCAUX	VCCAUX	M10	VCCAUX
VCCAUX	VCCAUX	V10	VCCAUX
VCCINT	VCCINT	H9	VCCINT
VCCINT	VCCINT	H11	VCCINT
VCCINT	VCCINT	J8	VCCINT
VCCINT	VCCINT	K11	VCCINT
VCCINT	VCCINT	L8	VCCINT
VCCINT	VCCINT	L10	VCCINT

Right Half of FG400 Package (Top View)

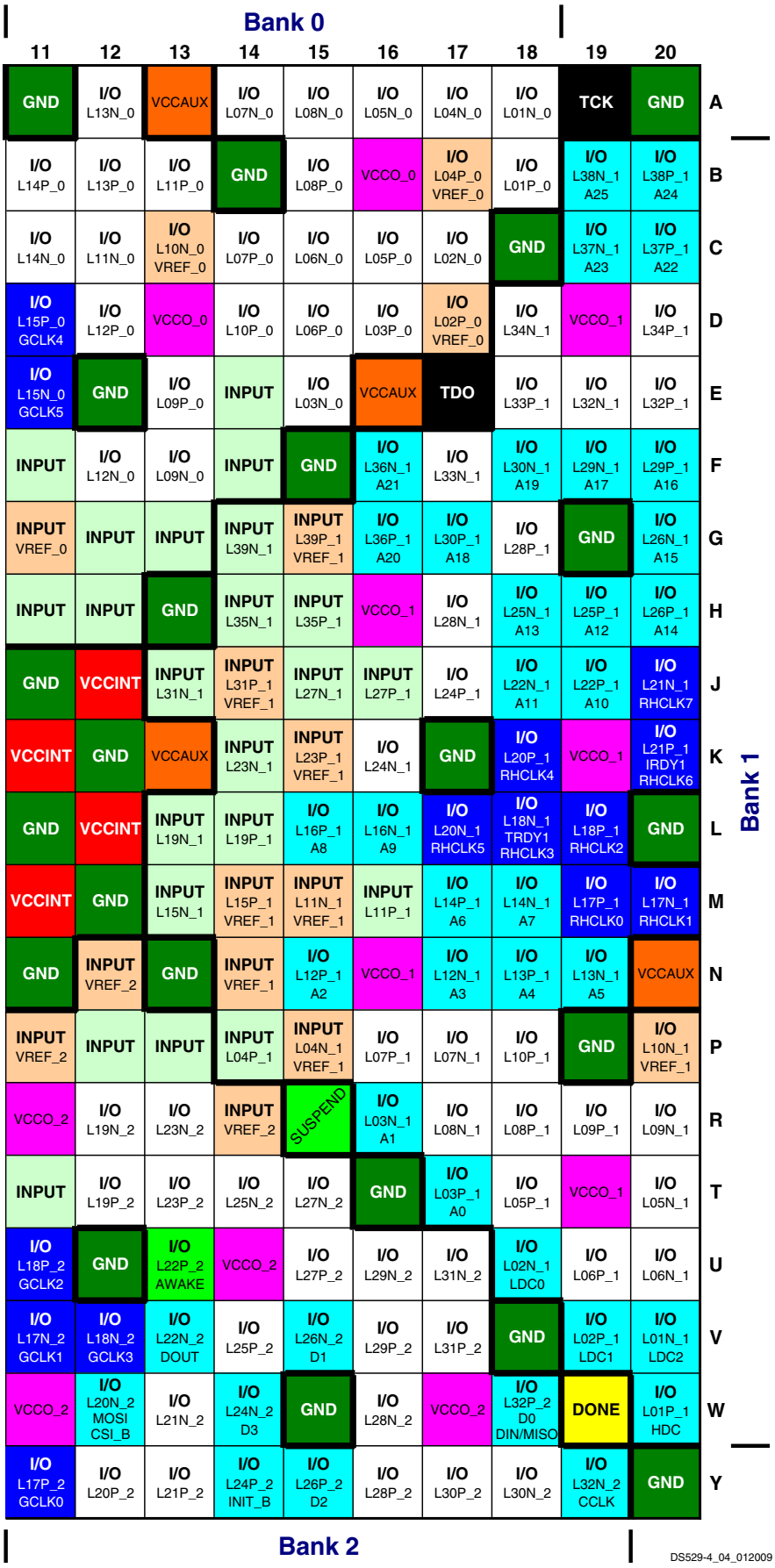


Table 83: **Spartan-3A FG484 Pinout*(Continued)***

Bank	Pin Name	FG484 Ball	Type
0	IO_L30P_0	E9	I/O
0	IO_L31N_0	B4	I/O
0	IO_L31P_0	A4	I/O
0	IO_L32N_0	D5	I/O
0	IO_L32P_0	C5	I/O
0	IO_L33N_0	B3	I/O
0	IO_L33P_0	A3	I/O
0	IO_L34N_0	F8	I/O
0	IO_L34P_0	E7	I/O
0	IO_L35N_0	E6	I/O
0	IO_L35P_0	F7	I/O
0	IO_L36N_0/PUDC_B	A2	DUAL
0	IO_L36P_0/VREF_0	B2	VREF
0	IP_0	E16	INPUT
0	IP_0	E8	INPUT
0	IP_0	F10	INPUT
0	IP_0	F12	INPUT
0	IP_0	F16	INPUT
0	IP_0	G10	INPUT
0	IP_0	G11	INPUT
0	IP_0	G12	INPUT
0	IP_0	G13	INPUT
0	IP_0	G14	INPUT
0	IP_0	G15	INPUT
0	IP_0	G16	INPUT
0	IP_0	G7	INPUT
0	IP_0	G9	INPUT
0	IP_0	H10	INPUT
0	IP_0	H13	INPUT
0	IP_0	H14	INPUT
0	IP_0/VREF_0	G8	VREF
0	IP_0/VREF_0	H12	VREF
0	IP_0/VREF_0	H9	VREF
0	VCCO_0	B10	VCCO
0	VCCO_0	B14	VCCO
0	VCCO_0	B18	VCCO
0	VCCO_0	B5	VCCO
0	VCCO_0	F14	VCCO
0	VCCO_0	F9	VCCO
1	IO_L01N_1/LDC2	Y21	DUAL

Table 83: **Spartan-3A FG484 Pinout*(Continued)***

Bank	Pin Name	FG484 Ball	Type
1	IO_L01P_1/HDC	AA22	DUAL
1	IO_L02N_1/LDC0	W20	DUAL
1	IO_L02P_1/LDC1	W19	DUAL
1	IO_L03N_1/A1	T18	DUAL
1	IO_L03P_1/A0	T17	DUAL
1	IO_L05N_1	W21	I/O
1	IO_L05P_1	Y22	I/O
1	IO_L06N_1	V20	I/O
1	IO_L06P_1	V19	I/O
1	IO_L07N_1	V22	I/O
1	IO_L07P_1	W22	I/O
1	IO_L09N_1	U21	I/O
1	IO_L09P_1	U22	I/O
1	IO_L10N_1	U19	I/O
1	IO_L10P_1	U20	I/O
1	IO_L11N_1	T22	I/O
1	IO_L11P_1	T20	I/O
1	IO_L13N_1	T19	I/O
1	IO_L13P_1	R20	I/O
1	IO_L14N_1	R22	I/O
1	IO_L14P_1	R21	I/O
1	IO_L15N_1/VREF_1	P22	VREF
1	IO_L15P_1	P20	I/O
1	IO_L17N_1/A3	P18	DUAL
1	IO_L17P_1/A2	R19	DUAL
1	IO_L18N_1/A5	N21	DUAL
1	IO_L18P_1/A4	N22	DUAL
1	IO_L19N_1/A7	N19	DUAL
1	IO_L19P_1/A6	N20	DUAL
1	IO_L20N_1/A9	N17	DUAL
1	IO_L20P_1/A8	N18	DUAL
1	IO_L21N_1/RHCLK1	L22	RHCLK
1	IO_L21P_1/RHCLK0	M22	RHCLK
1	IO_L22N_1/TRDY1/RHCLK3	L20	RHCLK
1	IO_L22P_1/RHCLK2	L21	RHCLK
1	IO_L24N_1/RHCLK5	M20	RHCLK
1	IO_L24P_1/RHCLK4	M18	RHCLK
1	IO_L25N_1/RHCLK7	K19	RHCLK
1	IO_L25P_1/IRDY1/RHCLK6	K20	RHCLK
1	IO_L26N_1/A11	J22	DUAL

Table 87: **Spartan-3A FG676 Pinout*(Continued)***

Bank	Pin Name	FG676 Ball	Type
0	IO_L34N_0	D10	I/O
0	IO_L34P_0	C10	I/O
0	IO_L35N_0	H12	I/O
0	IO_L35P_0	G12	I/O
0	IO_L36N_0	B9	I/O
0	IO_L36P_0	A9	I/O
0	IO_L37N_0	D9	I/O
0	IO_L37P_0	E10	I/O
0	IO_L38N_0	B8	I/O
0	IO_L38P_0	A8	I/O
0	IO_L39N_0	K12	I/O
0	IO_L39P_0	J12	I/O
0	IO_L40N_0	D8	I/O
0	IO_L40P_0	C8	I/O
0	IO_L41N_0	C6	I/O
0	IO_L41P_0	B6	I/O
0	IO_L42N_0	C7	I/O
0	IO_L42P_0	B7	I/O
0	IO_L43N_0	K11	I/O
0	IO_L43P_0	J11	I/O
0	IO_L44N_0	D6	I/O
0	IO_L44P_0	C5	I/O
0	IO_L45N_0	B4	I/O
0	IO_L45P_0	A4	I/O
0	IO_L46N_0	H10	I/O
0	IO_L46P_0	G10	I/O
0	IO_L47N_0	H9	I/O
0	IO_L47P_0	G9	I/O
0	IO_L48N_0	E7	I/O
0	IO_L48P_0	F7	I/O
0	IO_L51N_0	B3	I/O
0	IO_L51P_0	A3	I/O
0	IO_L52N_0/PUDC_B	G8	DUAL
0	IO_L52P_0/VREF_0	F8	VREF
0	IP_0	A5	INPUT
0	IP_0	A7	INPUT
0	IP_0	A13	INPUT
0	IP_0	A17	INPUT
0	IP_0	A23	INPUT
0	IP_0	C4	INPUT

Table 87: **Spartan-3A FG676 Pinout*(Continued)***

Bank	Pin Name	FG676 Ball	Type
0	IP_0	D12	INPUT
0	IP_0	D15	INPUT
0	IP_0	D19	INPUT
0	IP_0	E11	INPUT
0	IP_0	E18	INPUT
0	IP_0	E20	INPUT
0	IP_0	F10	INPUT
0	IP_0	G14	INPUT
0	IP_0	G16	INPUT
0	IP_0	H13	INPUT
0	IP_0	H18	INPUT
0	IP_0	J10	INPUT
0	IP_0	J13	INPUT
0	IP_0	J15	INPUT
0	IP_0/VREF_0	D7	VREF
0	IP_0/VREF_0	D14	VREF
0	IP_0/VREF_0	G11	VREF
0	IP_0/VREF_0	J17	VREF
0	N.C. (◆)	A24	N.C.
0	N.C. (◆)	B24	N.C.
0	N.C. (◆)	D5	N.C.
0	N.C. (◆)	E9	N.C.
0	N.C. (◆)	F18	N.C.
0	N.C. (◆)	E6	N.C.
0	N.C. (◆)	F9	N.C.
0	N.C. (◆)	G18	N.C.
0	VCCO_0	B5	VCCO
0	VCCO_0	B11	VCCO
0	VCCO_0	B16	VCCO
0	VCCO_0	B22	VCCO
0	VCCO_0	E8	VCCO
0	VCCO_0	E13	VCCO
0	VCCO_0	E19	VCCO
0	VCCO_0	H11	VCCO
0	VCCO_0	H16	VCCO
1	IO_L01N_1/LDC2	Y21	DUAL
1	IO_L01P_1/HDC	Y20	DUAL
1	IO_L02N_1/LDC0	AD25	DUAL
1	IO_L02P_1/LDC1	AE26	DUAL
1	IO_L03N_1/A1	AC24	DUAL

User I/Os by Bank

Table 88 indicates how the 502 available user-I/O pins are distributed between the four I/O banks on the FG676 package. The AWAKE pin is counted as a dual-purpose I/O.

Table 88: **User I/Os Per Bank for the XC3S1400A in the FG676 Package**

Package Edge	I/O Bank	Maximum I/O	All Possible I/O Pins by Type				
			I/O	INPUT	DUAL	VREF	CLK
Top	0	120	82	20	1	9	8
Right	1	130	67	15	30	10	8
Bottom	2	120	67	14	21	10	8
Left	3	132	97	18	0	9	8
TOTAL		**502**	**313**	**67**	**52**	**38**	**32**

Footprint Migration Differences

The XC3S1400A FPGA is the only Spartan-3A device offered in the FG676 package. However, Table 89 summarizes footprint and functionality differences between the XC3S1400A and the XC3SD1800A in the Spartan-3A DSP family. There are 17 unconnected balls in the XC3S1400A that become 16 input-only pins and one I/O pin in the XC3SD1800A. All other pins not listed in Table 89 unconditionally migrate between the Spartan-3A devices and the Spartan-3A DSP devices available in the FG676 package. The arrows indicate the direction for easy migration. For more details on the Spartan-3A DSP family and pinouts, and additional differences in the FG676 pinout for the XC3SD3400A device, see DS610.

Table 89: **FG676 Footprint Differences**

Pin	Bank	XC3S1400A	Migration	XC3SD1800A
A24	0	N.C.	→	INPUT
B24	0	N.C.	→	INPUT
D5	0	N.C.	→	INPUT
E6	0	N.C.	→	VREF (INPUT)
E9	0	N.C.	→	INPUT
F9	0	N.C.	→	VREF (INPUT)
F18	0	N.C.	→	INPUT
G18	0	N.C.	→	VREF (INPUT)
W18	2	N.C.	→	VREF (INPUT)
Y8	2	N.C.	→	VREF (INPUT)
Y18	2	N.C.	→	INPUT
Y19	2	N.C.	→	INPUT
AA8	2	N.C.	→	INPUT
AC5	2	N.C.	→	INPUT
AC22	2	N.C.	→	I/O
AD5	2	N.C.	→	INPUT
AD23	2	N.C.	→	VREF(INPUT)
DIFFERENCES			**17**	

Legend:

→ This pin can unconditionally migrate from the device on the left to the device on the right. Migration in the other direction is possible depending on how the pin is configured for the device on the right.